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Developing a Novel Fuzzy Evaluation Model by One-Sided Specification Capability Indices

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Abstract: When all of the one-sided specification indices of each quality characteristic reach the requirements of the process quality level, they can ensure that the process capability of the product meets the requirements of the process quality level. This study constructs a fuzzy membership function based on the upper confidence limit of the index, derives the fuzzy critical value, and then labels the fuzzy critical value on the axis of the visualized radar chart as well as connects adjacent critical points to shape a regular polygonal critical region. Next, this study calculates the observed value of the index to estimate and mark it on the axis for forming a visualized fuzzy radar evaluation chart. Obviously, this fuzzy evaluation model not only reduces the testing cost but also makes the quality level quickly meet the requirements of the specifications. Further, the radar chart can reduce the risk of misjudgment attributable to sampling errors and help improve the accuracy of evaluation by a confidence-upper-limit-based fuzzy evaluation model. Therefore, this easy-to-use visualized fuzzy radar evaluation chart is used as an evaluation interface, which has good and convenient management performance to identify and improve critical-to-quality quickly. Improving the quality of the process before the product is completed will also have the advantage of reducing social losses and environmental damage costs.

Keywords: process capability indices; membership function; fuzzy critical value; one-sided specification capability indices; radar chart



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1. Introduction

The output value of Taiwan's machine tools is ranked seventh in the world, mainly sold to countries with emerging markets, such as Southeast Asia and Eastern Europe, and the export volume is ranked fifth in the world. About 70% of precision machinery, machine tool, and component factories are located in the central region, combining the aerospace and smart machinery industries, as well as connecting the component processing and maintenance industries to form a large settlement for the machine tool and machinery industry [1–3]. According to Prahalad and Hamel [4] and Grossman and Helpman [5], in order to reduce operating costs and concentrate resources to give full play to their own core technologies, companies will outsource some non-core businesses to professional manufacturers to improve their overall efficiency and competitiveness. Driven by the highly clustered effect of Taiwan's machine tool industry, central Taiwan has become a complete machine tool industry chain and has established a key position in the global machine tool industry.

Machine tools have many important components, such as shafts, bearings, gears, etc. According to numerous studies, these important components usually contain multiple

quality characteristics (QC) of the smaller-the-better, the larger-the-better, and the nominal-the-best types at the same time. Each quality characteristic must meet the requirement of the quality level to ensure the product quality of the machine tool [6–15]. Process Capability Indices (PCIs) are not only a helpful tool for internal engineers to evaluate and analyze process capabilities but also a good communication tool between manufacturers [16–18]. Kane [19] proposed three process-yield-based capability indices, currently the most widely used indicators in the industry [20–23]. As noted by Chen et al. [15], the index C_{PU} is suitable for the process of the smaller-the-better (STB) quality characteristic, whereas C_{PL} is suitable for the process of the larger-the-better (LTB) quality characteristic. These two one-sided specification capability indices are explained as follows:

$$C_{PU} = \frac{USL - \mu}{3\sigma}, \quad (1)$$

$$C_{PL} = \frac{\mu - LSL}{3\sigma}, \quad (2)$$

where μ is the process mean and σ is the process standard deviation; USL and LSL refer to the upper specification limit and the lower specification limit, respectively. Based on Boyles [24], the relationship of indices and process yield is $Yield\% = \Phi(3C_{PI})$, where $C_{PI} = C_{PU}$ or C_{PL} , and $\Phi(\cdot)$ is the cumulative distribution function of standard normal distribution. Furthermore, C_{PK} suits the process of the nominal-the-better (NTB) quality characteristic. This two-sided specification index can be expressed as follows:

$$C_{PK} = \min\{C_{PU}, C_{PL}\} \quad (3)$$

For the sake of generality, this study assumes that the important components of the machine tools have b two-sided and u one-sided specification quality characteristics. Since the two-sided specification index C_{PK} is the minimum value derived from the one-sided specification indices C_{PU} and C_{PL} , consequently, this study will decompose it into two one-sided specification indices. Therefore, the process capability of an entire component can be evaluated by q one-sided specification process capability indices, in which $q = 2 \times b + u$. When the process capability indices of all one-sided specification indices meet the requirements of process capabilities, it is ensured that all quality characteristics are also consistent with the requirements of process capabilities. The radar chart is a visualized evaluation tool, which has been widely applied to various fields, such as engineering, management, education, and others [25–29]. Next, this study combined the upper-confidence-limit-based fuzzy evaluation rules with the radar chart with h lines to establish a visualized fuzzy radar evaluation chart. Apparently, this fuzzy radar evaluation chart is on the basis of rigorous statistical inferences. In addition, the evaluation criteria are established by an accurate fuzzy testing method. Finally, the easy-to-use visualized radar chart is used as an evaluation interface, which has good and convenient management performance to identify and improve critical-to-quality quickly. Therefore, this fuzzy radar evaluation chart is not only simple but also easy to use. Furthermore, it also can reduce the risk of misjudgment caused by sampling errors as well as improve the accuracy of the assessment. Improving the quality of the process before the product is completed will also have the advantage of reducing social losses and environmental damage costs.

The remainder of this paper is organized as follows: In Section 2, we present the estimations of process quality indices, including finding a *maximum likelihood estimator* (MLE) of one-sided specification capability indices and its $100(1 - \alpha)\%$ upper confidence limits. In Section 3, we derive the fuzzy critical values based on the upper confidence limits. Subsequently, fuzzy testing rules are established by the index estimates and the fuzzy critical values. According to the fuzzy testing rules, In Section 4, a simple and handy visualized radar evaluation chart is constructed as an evaluation interface. Finally, conclusions are made in Section 5.

2. Estimations of Process Quality Indices

A lot of studies have indicated that if the required process capability of a product is v' , then the required value v' of the process capability of an individual quality characteristic must be greater than v [2,30,31]. As mentioned above, when the process capability for each quality characteristic meets the requirement, it can be claimed as a qualified product or component. Since this study decomposed the two-sided specification index C_{PK} into two one-sided specification indices C_{PU} and C_{PL} , all the evaluated q one-sided specification indices of the product or component must meet the process capability requirement before it can be claimed as a qualified product or component.

According to Chen et al. [15], this study used Event E_h , representing the index value of the quality characteristic h is greater than v' ($C_{Ph} > v'$), and lets $E = \bigcap_h E_h$. Based on Boole's inequality and DeMorgan's theorem, the two one-sided specification indices in this study can be indicated in the following equation:

$$p(E) = p\left(\bigcap_h E_h\right) = 1 - p\left(\bigcup_{h=1}^q E_h^C\right) \geq 1 - \sum_{h=1}^q p(E_h^C), \quad (4)$$

where E_h^C refers to the complement of event E_h . Given the relationship between the index value and the yield, Equation (4) can be rewritten as follows:

$$\Phi(3v) = 1 - \sum_{h=1}^q [1 - \Phi(3v')]. \quad (5)$$

Therefore,

$$v' = \frac{1}{3} \Phi^{-1} \left(1 - \frac{1 - \Phi(3v)}{5} \right). \quad (6)$$

Obviously, when the process capability index value for each evaluated one-sided specification index is greater than v' ($C_{Ph} > v'$), then the entire product or component can be guaranteed to be a good or qualified product.

As mentioned above, the process capability of the product or component can be assessed by the process capability indices of q one-sided specifications. Let $(X_{h1}, \dots, X_{hj}, \dots, X_{hn})$, which is a set of random samples estimating the value of the h^{th} process capability index, whose population is the normal distribution with mean μ_h and standard deviation σ_h , where $h = 1, 2, \dots, q$. Therefore, the sample mean and sample standard deviation can be shown respectively, as follows:

$$\bar{X}_h = \frac{1}{n} \sum_{j=1}^n X_{hj} \quad (7)$$

and

$$S_h = \sqrt{\frac{1}{n} \sum_{j=1}^n (X_{hj} - \bar{X}_h)^2} \quad (8)$$

Let

$$C_{Ph} = \begin{cases} C_{PU}, & \text{quality characteristic } h \in STB \\ C_{PL}, & \text{quality characteristic } h \in LTB \end{cases} \quad (9)$$

Then, the estimators of the process capability index C_{Ph} are written below:

$$C_{Ph}^* = \begin{cases} \frac{USL_h - \bar{X}_h}{3S_h}, & \text{quality characteristic } h \in STB \\ \frac{\bar{X}_h - LSL_h}{3S_h}, & \text{quality characteristic } h \in LTB \end{cases} \quad (10)$$

Under the assumption of normality, S_h^{-1} is delivered as $(n/\sigma_h)K^{-1/2}$, where $K = nS_h^2/\sigma_h^2$ is distributed as χ_{n-1}^2 . Therefore,

$$\begin{aligned} p\{K \leq \chi_{1-\alpha/2;n-1}^2\} &= 1 - \alpha/2 \\ \Rightarrow p\left\{\frac{nS_h^2}{\sigma_h^2} \leq \chi_{1-\alpha/2;n-1}^2\right\} &= 1 - \alpha/2 \\ \Rightarrow p\left\{\sigma_h \geq \sqrt{\frac{n}{\chi_{1-\alpha/2;n-1}^2}} S_h\right\} &= 1 - \alpha/2. \end{aligned} \quad (11)$$

where $\chi_{1-\alpha/2;n-1}^2$ is the lower $1 - \alpha/2$ quantile of χ_{n-1}^2 .

Given the smaller-the-better quality characteristic, let

$$Z = 3\sqrt{n}\left(C_{Ph} - C_{Ph}^*\left(\frac{S_h}{\sigma_h}\right)\right) \quad (12)$$

Then the random variable Z is distributed as standard normal distribution. Consequently,

$$\begin{aligned} p\{Z \leq Z_{\alpha/2}\} &= 1 - \alpha/2 \\ \Rightarrow p\left\{3\sqrt{n}\left(C_{Ph} - C_{Ph}^*\left(\frac{S_h}{\sigma_h}\right)\right) \leq Z_{\alpha/2}\right\} &= 1 - \alpha/2 \\ \Rightarrow p\left\{C_{Ph} \leq C_{Ph}^*\left(\frac{S_h}{\sigma_h}\right) + \frac{Z_{\alpha/2}}{3\sqrt{n}}\right\} &= 1 - \alpha/2. \end{aligned} \quad (13)$$

where $Z_{\alpha/2}$ is the upper $\alpha/2$ quantile of $N(0, 1)$.

Given the larger-the-better quality characteristic, let

$$Z = 3\sqrt{n}\left(C_{Ph}^*\left(\frac{S_h}{\sigma_h}\right) - C_{Ph}\right) \quad (14)$$

Then the random variable Z is regarded as a standard normal distribution. Therefore,

$$\begin{aligned} p\{Z \geq -Z_{\alpha/2}\} &= 1 - \alpha/2 \\ \Rightarrow p\left\{3\sqrt{n}\left(C_{Ph}^*\left(\frac{S_h}{\sigma_h}\right) - C_{Ph}\right) \geq -Z_{\alpha/2}\right\} &= 1 - \alpha/2 \\ \Rightarrow p\left\{C_{Ph} \leq C_{Ph}^*\left(\frac{S_h}{\sigma_h}\right) + \frac{Z_{\alpha/2}}{3\sqrt{n}}\right\} &= 1 - \alpha/2. \end{aligned} \quad (15)$$

In addition, let Event E_{h1} and Event E_{h2} be expressed below:

$$E_{h1} = \left\{C_{Ph} \leq C_{Ph}^*\left(\frac{S_h}{\sigma_h}\right) + \frac{Z_{\alpha/2}}{3\sqrt{n}}\right\} \text{ and } E_{h2} = \left\{\sigma_h \geq \sqrt{\frac{n}{\chi_{1-\alpha/2;n-1}^2}} S_h\right\}$$

In addition, the compliments of Event E_{h1} and Event E_{h2} are indicated in the following:

$$E_{h1}^C = \left\{C_{Ph} > C_{Ph}^*\left(\frac{S_h}{\sigma_h}\right) + \frac{Z_{\alpha/2}}{3\sqrt{n}}\right\} \text{ and } E_{h2}^C = \left\{\sigma_h < \sqrt{\frac{n}{\chi_{1-\alpha/2;n-1}^2}} S_h\right\}$$

Given DeMorgan's rules and Boole's inequality, it is learned:

$$p(E_{h1} \cap E_{h2}) \geq 1 - p(E_{h1}^C) - p(E_{h2}^C) = 1 - \alpha \quad (16)$$

Thus,

$$p\left\{C_{Ph} \leq C_{Ph}^*\left(\frac{S_h}{\sigma_h}\right) + \frac{Z_{\alpha/2}}{3\sqrt{n}}, \sigma_h \geq \sqrt{\frac{n}{\chi_{1-\alpha/2;n-1}^2}} S_h\right\} \geq 1 - \alpha \quad (17)$$

Equivalently,

$$p \left\{ C_{Ph} \leq C_{Ph}^* \sqrt{\frac{\chi_{1-\alpha/2; n-1}^2}{n}} + \frac{Z_{\alpha/2}}{3\sqrt{n}} \right\} \geq 1 - \alpha \quad (18)$$

Let \bar{x}_h and s_h be the observed values of \bar{X}_h and S_h respectively, as follows:

$$\bar{x}_h = \frac{1}{n} \sum_{i=1}^n x_{hi} \quad (19)$$

and

$$s_h = \sqrt{\frac{1}{n-1} \sum_{i=1}^n (x_{hi} - \bar{x}_h)^2} \quad (20)$$

Thus, the observed value of C_{Ph}^* and the upper confidence limit of C_{Ph} respectively are expressed as follows:

$$C_{Ph0}^* = \begin{cases} \frac{USL_h - \bar{x}_h}{3s_h}, & \text{quality characteristic } h \in STB \\ \frac{\bar{x}_h - LSL_h}{3s_h}, & \text{quality characteristic } h \in LTB \end{cases} \quad (21)$$

and

$$UC_{Ph} = C_{Ph0}^* \sqrt{\frac{\chi_{1-\alpha/2; n-1}^2}{n}} + \frac{Z_{\alpha/2}}{3\sqrt{n}}. \quad (22)$$

3. Fuzzy Hypothesis Testing

The Fuzzy hypothesis testing is an effective approach to a decision whether process capability is acceptable [16,32–35]. Pearn and Chen [36] have defined the capability requirement is shown in Table 1 as follows:

Table 1. The capability level and corresponding index values.

| Capability Level | Index Values |
|------------------|---------------------------|
| Inadequate | $C_{Ph} < 1.00$ |
| Capable | $1.00 \leq C_{Ph} < 1.33$ |
| Satisfactory | $1.33 \leq C_{Ph} < 1.50$ |
| Excellent | $1.50 \leq C_{Ph} < 2.00$ |
| Superb | $2.00 \leq C_{Ph}$ |

It is assumed that a product or component contains a total of q corresponding one-sided specification evaluation indicators. If the process capability index values of the product are required to be at least v , then all of its corresponding q one-sided specification evaluation indices must be at least v' according to Equation (6). In order to determine whether the values of one-sided specification capability indices are larger or equal to v' , the hypothesis testing at significance level α can be stated as follows:

$$\begin{cases} H_0 : C_{ph} \geq v' & (\text{process capability meets the requirement}) \\ H_a : C_{ph} < v' & (\text{process capability dose not meet the requirement}) \end{cases} \quad (23)$$

As mentioned above, the null hypothesis H_0 is $C_{ph} \geq v'$, while the alternative hypothesis H_a is $C_{ph} < v'$. Given the above statistical test rules and the approach proposed by Chen [37], this study developed the fuzzy testing method based on the observed values of

upper confidence limits for index C_{ph} . As noted by Chen [38] and Lee et al. [39], the α -cuts of the triangular shaped fuzzy number \tilde{C}_{ph0}^* can be obtained as follows:

$$\tilde{C}_{ph0}^*[\alpha] = \begin{cases} [C_{ph0}^*(1), C_{ph0}^*(\alpha)], & \text{for } 0.01 \leq \alpha \leq 1 \\ [C_{ph0}^*(1), C_{ph0}^*(0.01)], & \text{for } 0 \leq \alpha \leq 0.01 \end{cases} \quad (24)$$

where

$$C_{ph0}^*(1) = C_{ph0}^* \sqrt{\frac{\chi_{0.5;n-1}^2}{n-1}} \quad (25)$$

$$C_{ph0}^*(\alpha) = C_{ph0}^* \sqrt{\frac{\chi_{1-\alpha/2;n-1}^2}{n}} + \frac{Z_{\alpha/2}}{3\sqrt{n}} \quad (26)$$

Therefore, the half-triangular shaped fuzzy number is $\tilde{C}_{ph0}^* = \Delta(C_{phM}, C_{phR})$, where

$$C_{phM} = C_{ph0}^*(1) = C_{ph0}^* \sqrt{\frac{\chi_{0.5;n-1}^2}{n-1}} \quad (27)$$

$$C_{phR} = C_{ph0}^*(0.01) = C_{ph0}^* \sqrt{\frac{\chi_{0.995;n-1}^2}{n}} + \frac{Z_{0.005}}{3\sqrt{n}} \quad (28)$$

Consequently, the membership function of the fuzzy number \tilde{C}_{ph0}^* is

$$\eta_h(x) = \begin{cases} 0 & \text{if } x < C_{phM} \\ 1 & \text{if } x = C_{phM} \\ \alpha & \text{if } C_{phM} < x < C_{phR} \\ 0 & \text{if } x \geq C_{phR} \end{cases} \quad (29)$$

where α is decided by $C_{ph0}^*(\alpha) = x$. Figure 1 exhibits a graph of the membership function $\eta_h(x)$ with the vertical line $x = v'$.

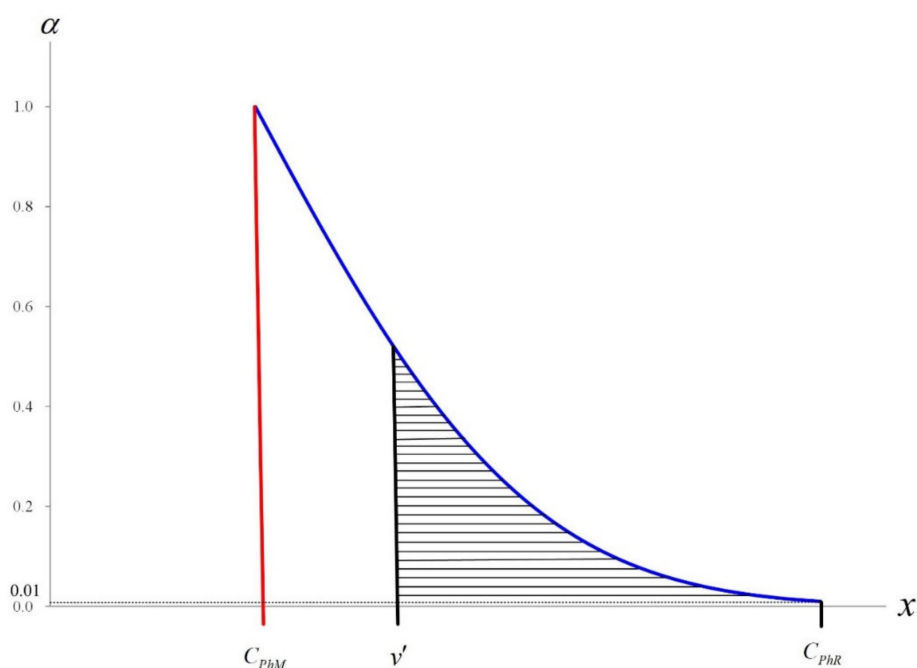


Figure 1. Membership function $\eta_h(x)$ with vertical line $x = v'$.

Based on the theories of Chen et al. [1] and Chen [40], if we let set A_{Th} be the area in the graph of $\eta_h(x)$ and set A_{Rh} be the area in the graph of $\eta_h(x)$ but to the right of the vertical line $x = v'$, then

$$A_{Th} = \{ (x, \alpha) | C_{PhM} \leq x \leq C_{Ph0}^*(\alpha), 0 \leq \alpha \leq 1 \} \quad (30)$$

And

$$A_{Rh} = \{ (x, \alpha) | v' \leq x \leq C_{Ph0}^*(\alpha), 0 \leq \alpha \leq 1 \} \quad (31)$$

Based on Equations (27) and (28), $d_{Rh} = C_{PhR} - v'$ and $d_{Th} = C_{PhR} - C_{PhM}$. Then

$$\frac{d_{Rh}}{2d_{Th}} = \frac{C_{PhR} - v'}{2(C_{PhR} - C_{PhM})} \quad (32)$$

As noted by Yu et al. [41], we let $0 < \phi \leq 0.5$. Then, the decision value dv_h of the h^{th} one-sided specification evaluation index can satisfy the following equation.

$$\frac{C_{PhR} - dv_h}{2d_{Th}} = \frac{C_{PhR} - dv_h}{2(C_{PhR} - C_{PhM})} = \phi \quad (33)$$

According to Equations (27) and (28), the decision value is $dv_h = A(\phi)C_{Ph0}^* + B(\phi)$ where

$$A(\phi) = (1 - 2\phi) \sqrt{\frac{\chi_{0.995; n-1}^2}{n-1}} + 2\phi \sqrt{\frac{\chi_{0.5; n-1}^2}{n-1}} \quad (34)$$

$$B(\phi) = (1 - 2\phi) \frac{Z_{0.005}}{3\sqrt{n}} \quad (35)$$

Based on Chen et al. [1] and Chen and Yu [42], the decision rules of fuzzy tests are:

- (1) If $dv_h \leq v'$ is equivalent to $d_{Rh}/2d_{Th} \leq \phi$, then reject H_0 and conclude that $C_{ph} < v'$.
- (2) If $dv_h > v'$ is equivalent to $d_{Rh}/2d_{Th} > \phi$, then do not reject H_0 and conclude that $C_{ph} \geq v'$.

In Equation (34), $dv_h \leq v'$ is equivalent to $C_{Ph0}^* \leq v_0$ where

$$v_0 = \frac{v' - B(\phi)}{A(\phi)} \quad (36)$$

According to Chen and Yu [42], we can call v_0 as a fuzzy critical value. The decision rules of fuzzy tests can be rewritten as follows:

- (1) If $C_{Ph0}^* \leq v_0$, then reject H_0 and conclude that $C_{ph} < v'$.
- (2) If $C_{Ph0}^* > v_0$, then do not reject H_0 and conclude that $C_{ph} \geq v'$.

4. Case Study

As mentioned above, the output value of Taiwan's machine tools ranks among the best in the world, and the central region is the main industrial cluster. Many products or important components processed by machine tools usually contain numerous quality characteristics of one-sided and two-sided specifications at the same time—gears, for example. After the inner circular hole of the gear is polished, it is necessary to confirm that the four quality characteristics—roundness, inner cylindrical surface roughness, deflection, and inner diameter—can meet the specification requirements for the subsequent assembly quality and post-assembly operation quality [30,43]. Among these four quality characteristics, roundness, inner cylindrical surface roughness, and deflection are considered as the smaller-the-better type, directly evaluated by the one-sided specification indices ($h = 1, 2, 3$) of the smaller-the-better type. Inner diameter belongs to the nominal-the-best type, so it can be evaluated by both a one-sided specification index ($h = 4$) of the smaller-the-better

type and a one-sided specification index ($h = 5$) of the larger-the-better type. The relevant information is shown in the following Table 2.

Table 2. Important quality characteristics and corresponding evaluation index values after the gear inner hole grinding.

| Tolerance Type | h | Specification Limit | Evaluation Index |
|----------------|-----|---------------------|---|
| one-sided | 1 | $USL_1 = 0.010$ | $C_{P10}^* = \frac{0.010 - \bar{x}_1}{3s_1}$ |
| one-sided | 2 | $USL_2 = 0.050$ | $C_{P20}^* = \frac{0.050 - \bar{x}_2}{3s_2}$ |
| one-sided | 3 | $USL_3 = 0.600$ | $C_{P30}^* = \frac{0.600 - \bar{x}_3}{3s_3}$ |
| two-sided | 4 | $USL_4 = 29.012$ | $C_{P40}^* = \frac{29.012 - \bar{x}_4}{3s_4}$ |
| two-sided | 5 | $LSL_5 = 28.988$ | $C_{P50}^* = \frac{28.988 - \bar{x}_5}{3s_5}$ |

Remark: unit μm .

Next, a random test follows. Sixty gears processed by a mechanical processing factory in central Taiwan were randomly selected. Based on the 60 sample data and the evaluation model mentioned earlier in this study, the evaluation steps were established as follows:

Step 1: Based on Table 1 and Equation (6), set the required capability index value of the gear grinding process as v and calculate the required value v' for each corresponding evaluation index as follows:

$$v = 1.33 \text{ (Satisfactory)}$$

$$v' = \frac{1}{3} \Phi^{-1} \left(1 - \frac{1 - \Phi(3 \times 1.33)}{5} \right) = 1.455$$

Step 2: Based on Equations (34) and (35), compute the values of $A(\phi)$ and $B(\phi)$, and then based on Equation (36), compute the fuzzy value of v_0 as follows:

$$A(\phi) = (1 - 2\phi) \sqrt{\frac{\chi_{0.995, n-1}^2}{n-1}} + 2\phi \sqrt{\frac{\chi_{0.5, n-1}^2}{n-1}} = 1.051$$

$$B(\phi) = (1 - 2\phi) \frac{Z_{0.005}}{3\sqrt{n}} = 0.067$$

$$v_0 = \frac{v' - B(\phi)}{A(\phi)} = 1.321$$

Step 3: Based on Equations (19) and (20), compute the values of \bar{x}_h and s_h , and then based on Equation (21), compute the critical values of \tilde{C}_{ph0}^* as follows:

Step 4: Draw 5 lines with an angle of 72 degrees, mark v_0 on the lines of the radar chart is shown in Figure 2, and connect adjacent critical points to build a regular pentagon critical region ($v_0 = 1.321$) as follows:

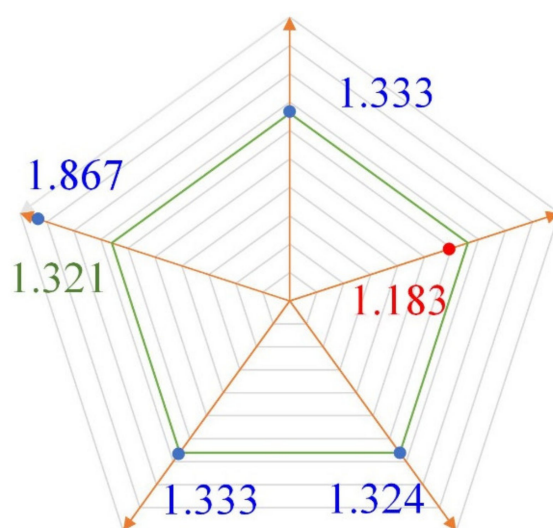


Figure 2. Critical region on a radar chart.

Step 5: Mark the estimated values of the five indicators ($h = 1, \dots, 5$) in Table 3 on the five lines and perform the evaluation task as follows:

1. When the index estimate \tilde{C}_{ph0}^* falls within the regular pentagon critical region, then reject H_0 and conclude that $C_{ph} < 1.455$.
2. When the index estimate \tilde{C}_{ph0}^* falls outside the regular pentagon critical region, then do not reject H_0 and conclude that $C_{ph} \geq 1.455$.

Table 3. The values of \bar{x}_h , s_h , C_{ph0}^* and UC_{ph} .

| Sample Mean (\bar{x}_h) | Sample Standard Deviation (s_h) | C_{ph0}^* | UC_{ph} |
|-----------------------------|-------------------------------------|---------------------|-------------------|
| $\bar{x}_1 = 0.0070$ | $s_1 = 0.00075$ | $C_{p10}^* = 1.333$ | $UC_{p1} = 1.644$ |
| $\bar{x}_2 = 0.0390$ | $s_2 = 0.00310$ | $C_{p20}^* = 1.183$ | $UC_{p2} = 1.468$ |
| $\bar{x}_3 = 0.4550$ | $s_3 = 0.03650$ | $C_{p30}^* = 1.324$ | $UC_{p3} = 1.634$ |
| $\bar{x}_4 = 29.002$ | $s_4 = 0.00250$ | $C_{p40}^* = 1.333$ | $UC_{p4} = 1.644$ |
| $\bar{x}_5 = 29.002$ | $s_5 = 0.00250$ | $C_{p50}^* = 1.867$ | $UC_{p5} = 2.268$ |

Step 6: The results and discussion are described as follows:

1. Considering the statistical testing rules, the five indicator values all met the requirement of the process quality level ($C_{ph} \geq 1.455$) since the upper limits of the five indicators were all greater than 1.455.
2. According to the fuzzy testing method proposed by this study, the estimated value of the evaluation index 2 was $C_{p20}^* = 1.183 < v_0 = 1.321$, which means that index 2 did not meet the quality level requirement. In fact, $C_{p20}^* = 1.183$ was much less than $v' = 1.455$, so applying the fuzzy testing method is more reasonable than the traditional statistical method.

5. Conclusions

This study disassembled a two-sided specification index into two one-sided specification indices and applied the one-sided specification index to propose a quality evaluation model for products or important components with multiple quality characteristics. The advantages of this evaluation model are illustrated as follows:

1. Given the upper confidence limit of the one-sided specification index, the risk of misjudgment caused by sampling errors can be reduced.
2. The precision of the evaluation can be advanced through the confidence-upper-limit-based fuzzy testing method.
3. The developed fuzzy critical values labeled on the radar chart are simple and easy to use.
4. Using the easy-to-use visualized radar chart as an evaluation interface can present a complete picture of all evaluation indicators, showing that it has good and convenient management performance.

In addition, the evaluation model proposed by this study can monitor all evaluation indicators at the same time to ensure that each index value can meet the requirement of the quality level. In practice, this model can assist the development of the industrial chain and promote quality improvement. Furthermore, this study used gears as an example. However, future studies can apply the proposed approach to products or important components with multiple quality characteristics in various fields, such as IC industry wire bonding, TFT LCD, and physical fitness, etc. Moreover, it is recommended this proposed model be applied to the selection of multiple suppliers or the comparison of the process performance of multiple production lines.

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